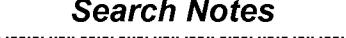


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/517,419	MARTINEZ ET AL.	
	Examiner	Art Unit	
	KRISTEN C. MATTER	3771	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner